

# Search Notes



Application/Control No.

09/942,665

Examiner

Tae H. Yoon

Applicant(s)/Patent under  
Reexamination

TAI ET AL.

Art Unit

1714

## SEARCHED

Class	Subclass	Date	Examiner
524	398		my
	503		
525	56		
	57		
428	34.1		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
524	398	12-17-05	my
	503		

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR